

Notice of References Cited	Application/Control No. 10/721,870	Applicant(s)/Patent Under Reexamination INOUE ET AL.	
	Examiner Caridad M. Everhart	Art Unit 2825	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,180,493	01-2001	Chu, Chih-Hsun	438/437
	C	US-6,258,695	07-2001	Dunn et al.	438/424
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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